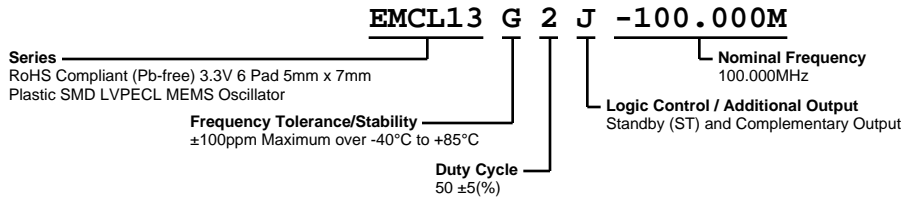


# EMCL13G2J-100.000M



## ELECTRICAL SPECIFICATIONS

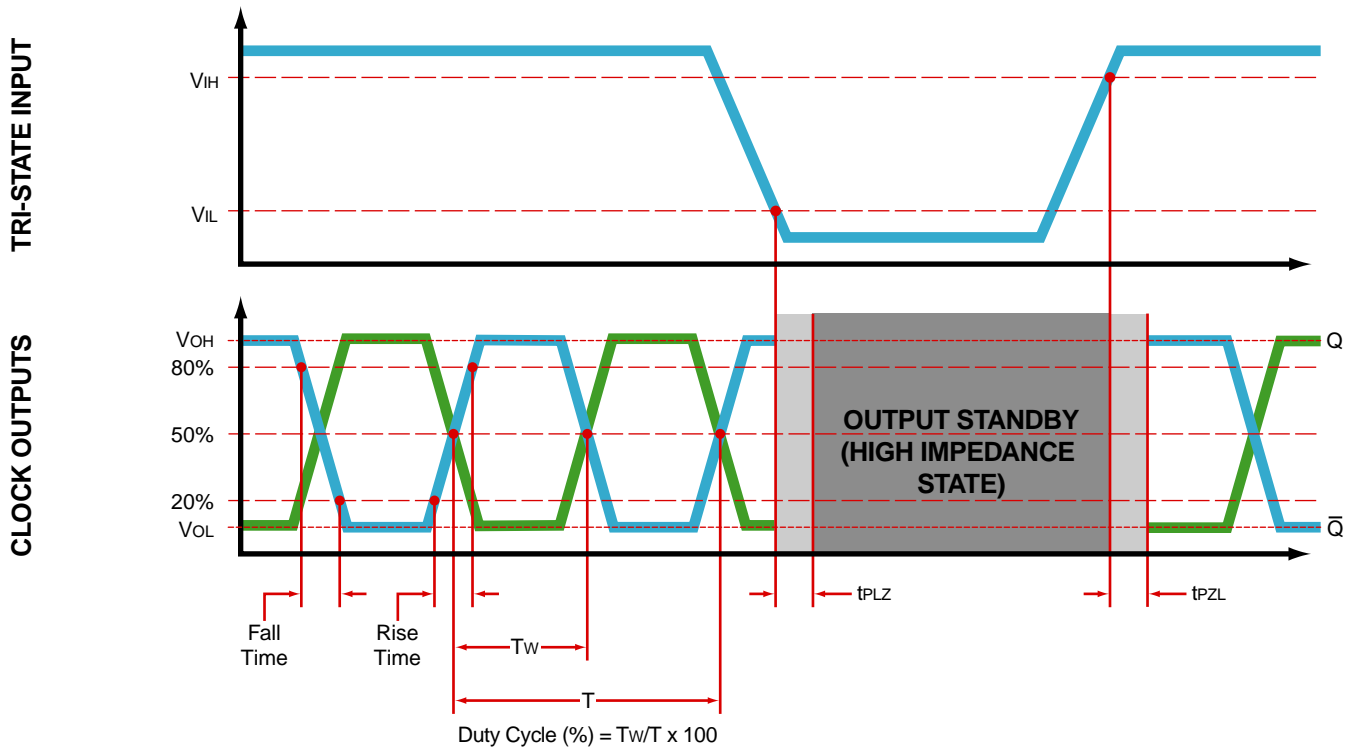
<b>Nominal Frequency</b>	100.000MHz
<b>Frequency Tolerance/Stability</b>	±100ppm Maximum over -40°C to +85°C (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, 1st Year Aging at 25°C, Reflow, Shock, and Vibration)
<b>Aging at 25°C</b>	±1ppm First Year Maximum
<b>Supply Voltage</b>	+3.3Vdc ±0.3Vdc
<b>Input Current</b>	80mA Maximum (Excluding Load Termination Current)
<b>Output Voltage Logic High (Voh)</b>	2.35Vdc Typical, Vcc-1.025Vdc Minimum
<b>Output Voltage Logic Low (Vol)</b>	1.6Vdc Typical, Vcc-1.62Vdc Maximum
<b>Rise/Fall Time</b>	150pSec Typical, 300pSec Maximum (Measured over 20% to 80% of waveform)
<b>Duty Cycle</b>	50 ±5(%) (Measured at 50% of waveform)
<b>Load Drive Capability</b>	50 Ohms into Vcc-2.0Vdc
<b>Output Logic Type</b>	LVPECL
<b>Logic Control / Additional Output</b>	Standby (ST) and Complementary Output
<b>Output Control Input Voltage</b>	Vih of 70% of Vcc Minimum or No Connect to Enable Output and Complementary Output, Vil of 30% of Vcc Maximum to Disable Output and Complementary Output (High Impedance)
<b>Standby Current</b>	30µA Maximum (ST) Without Load
<b>Period Jitter (Deterministic)</b>	0.2pSec Typical
<b>Period Jitter (Random)</b>	2.0pSec Typical
<b>Period Jitter (RMS)</b>	1.5pSec Typical, 3.0pSec Maximum
<b>Period Jitter (pk-pk)</b>	20pSec Typical, 25pSec Maximum
<b>RMS Phase Jitter (Fj = 637kHz to 10MHz; Random)</b>	1.7pSec Typical
<b>RMS Phase Jitter (Fj = 1MHz to 20MHz; Random)</b>	1.4pSec Typical
<b>RMS Phase Jitter (Fj = 1.875MHz to 20MHz; Random)</b>	1.1pSec Typical
<b>Start Up Time</b>	10mSec Maximum
<b>Storage Temperature Range</b>	-55°C to +125°C

## ENVIRONMENTAL & MECHANICAL SPECIFICATIONS

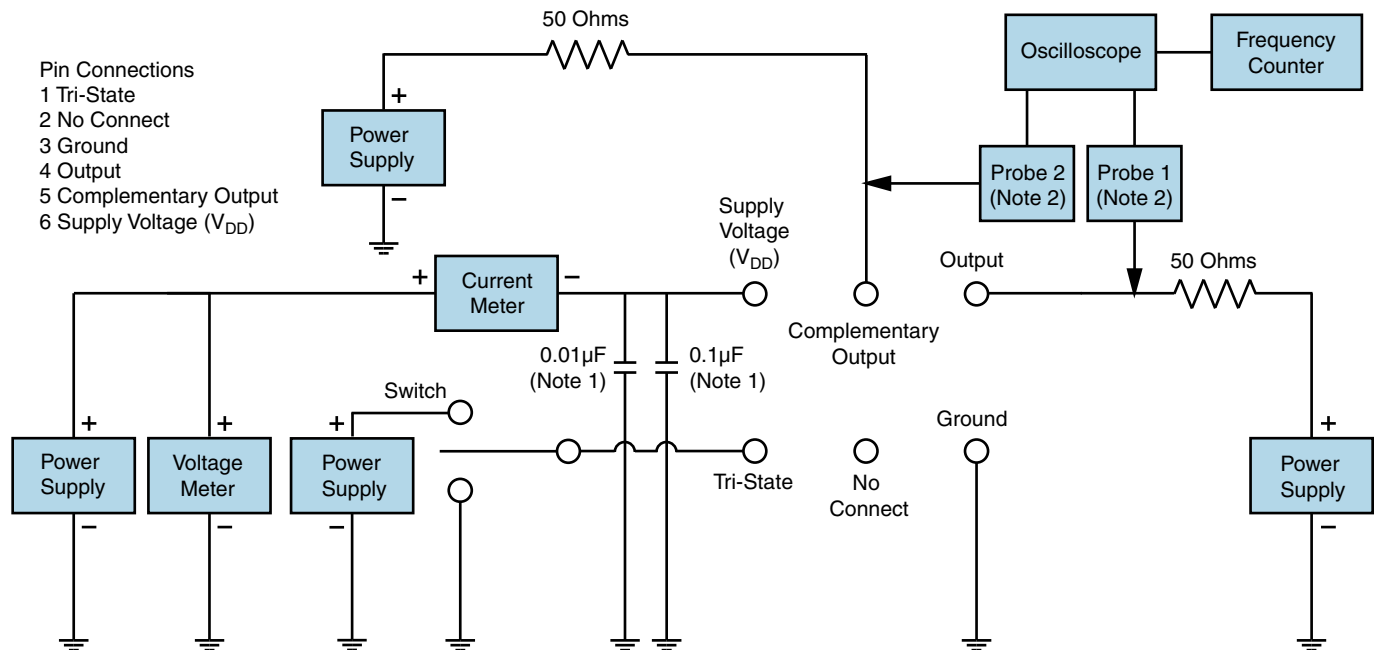
<b>ESD Susceptibility</b>	MIL-STD-883, Method 3015, Class 2, HBM 2000V
<b>Flammability</b>	UL94-V0
<b>Mechanical Shock</b>	MIL-STD-883, Method 2002, Condition G, 30,000G
<b>Moisture Resistance</b>	MIL-STD-883, Method 1004
<b>Moisture Sensitivity Level</b>	J-STD-020, MSL 1
<b>Resistance to Soldering Heat</b>	MIL-STD-202, Method 210, Condition K
<b>Resistance to Solvents</b>	MIL-STD-202, Method 215
<b>Solderability</b>	MIL-STD-883, Method 2003 (Six I/O Pads on bottom of package only)
<b>Temperature Cycling</b>	MIL-STD-883, Method 1010, Condition B
<b>Thermal Shock</b>	MIL-STD-883, Method 1011, Condition B
<b>Vibration</b>	MIL-STD-883, Method 2007, Condition A, 20G



## OUTPUT WAVEFORM & TIMING DIAGRAM



## Test Circuit for Tri-State and Complementary Output



Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close (less than 2mm) to the package ground and supply voltage pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>500MHz) passive probe is recommended.

Note 3: Test circuit PCB traces need to be designed for a characteristic line impedance of 50 ohms.

## Recommended Solder Reflow Methods



### High Temperature Infrared/Convection

<b><math>T_s</math> MAX to <math>T_L</math> (Ramp-up Rate)</b>	3°C/second Maximum
<b>Preheat</b>	
- Temperature Minimum ( $T_s$ MIN)	150°C
- Temperature Typical ( $T_s$ TYP)	175°C
- Temperature Maximum ( $T_s$ MAX)	200°C
- Time ( $t_s$ MIN)	60 - 180 Seconds
<b>Ramp-up Rate (<math>T_L</math> to <math>T_p</math>)</b>	3°C/second Maximum
<b>Time Maintained Above:</b>	
- Temperature ( $T_L$ )	217°C
- Time ( $t_L$ )	60 - 150 Seconds
<b>Peak Temperature (<math>T_p</math>)</b>	260°C Maximum for 10 Seconds Maximum
<b>Target Peak Temperature (<math>T_p</math> Target)</b>	250°C +0/-5°C
<b>Time within 5°C of actual peak (<math>t_p</math>)</b>	20 - 40 seconds
<b>Ramp-down Rate</b>	6°C/second Maximum
<b>Time 25°C to Peak Temperature (t)</b>	8 minutes Maximum
<b>Moisture Sensitivity Level</b>	Level 1

## Recommended Solder Reflow Methods



### Low Temperature Infrared/Convection 240°C

<b><math>T_S</math> MAX to <math>T_L</math> (Ramp-up Rate)</b>	5°C/second Maximum
<b>Preheat</b>	
- Temperature Minimum ( $T_S$ MIN)	N/A
- Temperature Typical ( $T_S$ TYP)	150°C
- Temperature Maximum ( $T_S$ MAX)	N/A
- Time ( $t_s$ MIN)	60 - 120 Seconds
<b>Ramp-up Rate (<math>T_L</math> to <math>T_P</math>)</b>	5°C/second Maximum
<b>Time Maintained Above:</b>	
- Temperature ( $T_L$ )	150°C
- Time ( $t_L$ )	200 Seconds Maximum
<b>Peak Temperature (<math>T_P</math>)</b>	240°C Maximum
<b>Target Peak Temperature (<math>T_P</math> Target)</b>	240°C Maximum 1 Time / 230°C Maximum 2 Times
<b>Time within 5°C of actual peak (<math>t_p</math>)</b>	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
<b>Ramp-down Rate</b>	5°C/second Maximum
<b>Time 25°C to Peak Temperature (t)</b>	N/A
<b>Moisture Sensitivity Level</b>	Level 1

### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

### High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum.